**SOT-23** 

PIN2 D

N-Channel MOSFET



## **Description**

The HSI8810TP uses advanced trench technology to provide excellent  $R_{\rm DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

### **General Features**

 $V_{DS} = 20V, I_D = 7A$   $R_{DS(ON)} < 17m\Omega$  @  $V_{GS} = 4.5V$  $R_{DS(ON)} < 25m\Omega$  @  $V_{GS} = 2.5V$ 

# Application @ Vgs=2.5V

High power and current handing capability Lead free product is acquired Surface mount package PWM applications

## **Package Marking and Ordering Information**

Product ID	Pack	Marking	Qty(PCS)
HSI8810TP	SOT-23	2320	3000PCS

## Absolute Maximum Ratings (T<sub>A</sub>=25 ℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
VDS	Drain-Source Voltage	20	V
V <sub>G</sub> s	Gate-Source Voltage	±12	V
Ι <sub>D</sub>	Drain Current-Continuous	7	Α
Ідм	Drain Current-Pulsed (Note 1)	32	Α
Po	Maximum Power Dissipation	2	W
T <sub>J</sub> ,T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 To 150	$^{\circ}\mathbb{C}$
Reja	Thermal Resistance,Junction-to-Ambient (Note 2)	120	°C/W



# **Electrical Characteristics** (TJ=25℃ unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Charac	teristic					
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	20	-	_	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V,	-	-	1.0	μA
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V	-	-	±100	nA
On Charac	teristics		•			
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	0.5	0.75	1.2	V
	Static Drain-Source on-Resistance	V <sub>GS</sub> =4.5V, I <sub>D</sub> =7A	-	15	17	mΩ
$R_{DS(on)}$		V <sub>GS</sub> =2.5V, I <sub>D</sub> =5A	-	19	25	
Dynamic C	Characteristics		•			
Ciss	Input Capacitance	101/11/101/	-	700	-	pF
Coss	Output Capacitance	V <sub>DS</sub> =10V, V <sub>GS</sub> =0V,	-	132	-	рF
Crss	Reverse Transfer Capacitance	f=1.0MHz	-	114	-	pF
Qg	Total Gate Charge	\/ -40\/ I -40	-	15	-	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{DS}$ =10V, $I_{D}$ =4A, $V_{GS}$ =4.5V	-	2	-	nC
$Q_{gd}$	Gate-Drain("Miller") Charge	VGS-4.5V	-	5.2	-	nC
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-on Delay Time	1014	-	9	-	ns
t <sub>r</sub>	Turn-on Rise Time	$V_{DS}$ =10V, $I_{D}$ =4A, $R_{GEN}$ =3 $\Omega$ ,	-	25	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time	$V_{GS}=4.5V$	-	37	-	ns
t <sub>f</sub>	Turn-off Fall Time	V GS-4.5 V	-	14	-	ns
Drain-Sou	rce Diode Characteristics and Maxim	ium Ratings				
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	7.5	А
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	32	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =8A	-	-	1.2	V

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

<sup>2.</sup> Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



# **Typical Performance Characteristics**

Figure1: Output Characteristics

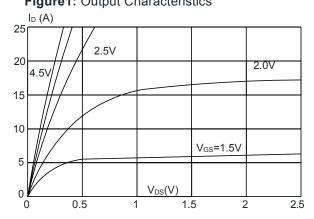


Figure 3:On-resistance vs. Drain Current

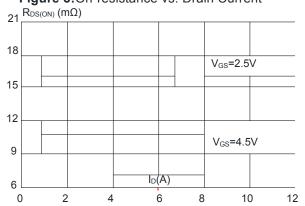


Figure 5: Gate Charge Characteristics

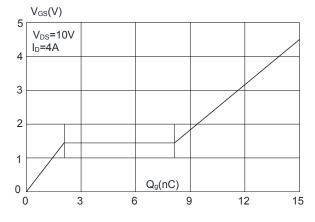


Figure 2: Typical Transfer Characteristics

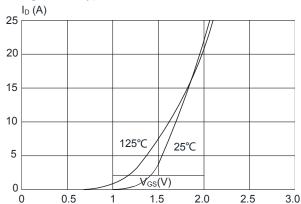


Figure 4: Body Diode Characteristics

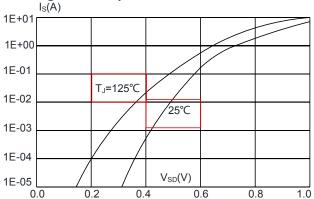
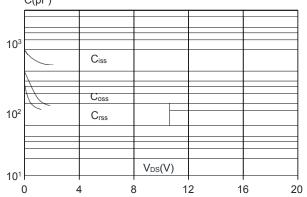


Figure 6: Capacitance Characteristics





**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature

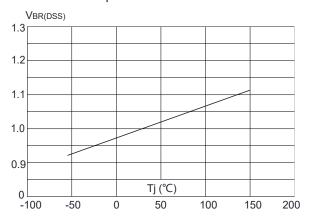
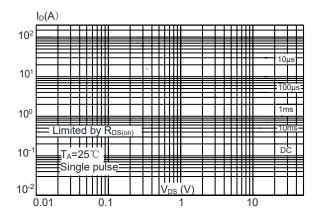
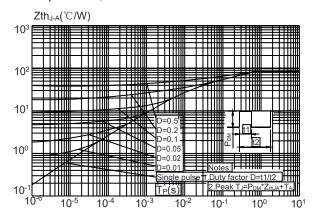


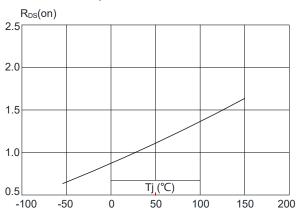
Figure 9: Maximum Safe Operating Area



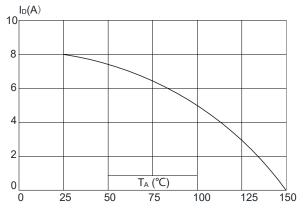
**Figure.11:** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



**Figure 8:** Normalized on Resistance vs. Junction Temperature

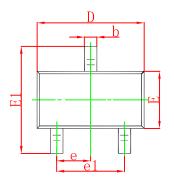


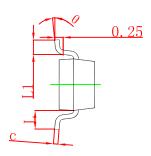
**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature

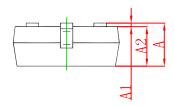




# **SOT-23 Package Outline Dimensions**

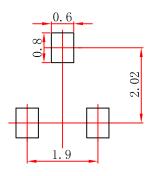






Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950 TYP		0.037 TYP		
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022 REF		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

# **SOT-23 Suggested Pad Layout**



#### Note

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:±0.05mm.
  3.The pad layout is for reference purposes only.



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